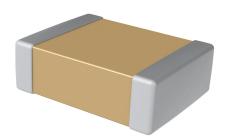
High Temperature 175°C, X7R Dielectric, 16 – 200 VDC (Industrial Grade)



Overview

KEMET's High Temperature X7R Dielectric capacitors are formulated and designed for extreme temperature applications. Constructed of a robust and proprietary base metal electrode (BME) dielectric system, these devices are capable of reliable operation in temperatures up to 175°C. Providing an attractive combination of performance and robustness in general high temperature applications, High Temperature X7R dielectric capacitors are well suited for high temperature bypass and decoupling applications or frequency discriminating circuits where Q and stability of capacitance characteristics are not critical. They exhibit a predictable change in capacitance with respect to time, voltage and temperature up to 175°C.



Ordering Information

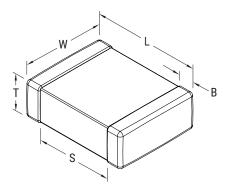
C	1210	R	225	K	3	R	A	С	T050
Ceramic	Case Size ¹ (L" x W")	Specification/ Series ¹	Capacitance Code (pF)	Capacitance Tolerance	Rated Voltage (VDC)	Dielectric	Failure Rate/ Design	Termination Finish	Packaging/Grade (C-Spec) ²
	0402 0603 0805 1206 1210 1812	G = 175°C with standard termination R = 175°C w/ Flexible Termination	First two digits represent significant figures. Third digit specifies number of zeros.	J = ±5% K = ±10% M = ±20%	4 = 16 3 = 25 5 = 50 1 = 100 2 = 200	R = X7R	A = N/A	C = 100% Matte Sn	Blank = Bulk 7292 = Waffle Pack/Tray TU = 7" Reel - Unmarked (full reel quantity) T050 = 50 pieces/ 7" Reel - Unmarked T100 = 100 pieces/ 7" Reel - Unmarked T250 = 250 pieces/ 7" Reel - Unmarked T500 = 500 pieces/ 7" Reel - Unmarked T1K0 = 1,000 pieces/ Reel - Unmarked

¹ Flexible termination option is only available in 0603 (1608 metric) and larger case sizes.

² Reeling quantities are dependent upon chip size and thickness dimension. When ordering using the "T1K0" packaging option, 1812 case size devices with chip thickness of ≥ 1.9 mm (nominal) may be shipped on multiple 7" reels or a single 13" reel. The term "Unmarked" pertains to laser marking of components. All packaging options labeled as "Unmarked" will contain capacitors that have not been laser marked. Additional reeling or packaging options may be available. Contact KEMET for details.



Dimensions - Millimeters (Inches) - Standard Termination



EIA Size Code	Metric Size Code	L Length	W Width	T Thickness	B Bandwidth	S Separation Minimum	Mounting Technique
0402	1005	1.00 (0.040) ±0.05 (0.002)	0.50 (0.020) ±0.05 (0.002)		0.30 (0.012) ±0.10 (0.004)	0.30 (0.012)	Solder Reflow Only
0603	1608	1.60 (0.063) ±0.15 (0.006)	0.80 (0.032) ±0.15 (0.006)		0.35 (0.014) ±0.15 (0.006)	0.70 (0.028)	0.11.14
0805	2012	2.00 (0.079) ±0.20 (0.008)	1.25 (0.049) ±0.20 (0.008)	See Table 2	0.50 (0.02) ±0.25 (0.010)	0.75 (0.030)	Solder Wave or
1206	3216	3.20 (0.126) ±0.20 (0.008)	1.60 (0.063) ±0.20 (0.008)	for Thickness	0.50 (0.02) ±0.25 (0.010)		Solder Reflow
1210	3225	3.20 (0.126) ±0.20 (0.008)	2.50 (0.098) ±0.20 (0.008)		0.50 (0.02) ±0.25 (0.010)	N/A	Solder Reflow Only
1812	4532	4.50 (0.177) ±0.30 (0.012)	3.20 (0.126) ±0.30 (0.012)		0.60 (0.024) ±0.35 (0.014)		Solder Reflow Only

Dimensions - Millimeters (Inches) - Flexible Termination

EIA Size Code	Metric Size Code	L Length	W Width	T Thickness	B Bandwidth	S Separation Minimum	Mounting Technique
0603	1608	1.60 (0.063) ±0.17 (0.007)	0.80 (0.032) ±0.15 (0.006)		0.45 (0.018) ±0.15 (0.006)	0.58 (0.023)	Colden Ways
0805	2012	2.00 (0.079) ±0.30 (0.012)	1.25 (0.049) ±0.30 (0.012)		0.50 (0.02) ±0.25 (0.010)	0.75 (0.030)	Solder Wave or Solder Reflow
1206	3216	3.30 (0.130) ±0.40 (0.016)	1.60 (0.063) ±0.35 (0.013)	See Table 2 for Thickness	0.60 (0.024) ±0.25 (0.010)		Solder Reliow
1210	3225	3.30 (0.130) ±0.40 (0.016)	2.60 (0.102) ±0.30 (0.012)		0.60 (0.024) ±0.25 (0.010)	N/A	Solder Reflow Only
1812	4532	4.50 (0.178) ±0.40 (0.016)	3.20 (0.126) ±0.30 (0.012)		0.70 (0.028) ±0.35 (0.014)		Solder Reflow Only



Overview cont'd

Concerned with flex cracks resulting from excessive stresses produced during board flexure and thermal cycling? These devices are available with KEMET's Flexible termination technology which inhibits the transfer of board stress to the rigid ceramic body, therefore mitigating flex cracks which can result in low IR or short circuit failures. Although flexible termination technology does not eliminate the potential for mechanical damage that

may propagate during extreme environmental and handling conditions, it does provide superior flex performance over standard termination systems.

KEMET's High Temperature X7R surface mount MLCCs are manufactured in state of the art ISO/TS 16949:2009 certified facilities and are proven to function reliably in harsh, high temperature and high humidity, down-hole environments.

Benefits

- Operating temperature range of -55°C to +175°C
- · Voltage derating not required
- · Lead (Pb)-free, RoHS and REACH compliant
- · Base metal electrode (BME) dielectric system
- EIA 0402, 0603, 0805, 1206, 1210, and 1812 case sizes
- DC voltage ratings of 16 V, 25 V, 50 V, 100 V, and 200 V
- Capacitance offerings ranging from 2.7 nF to 3.3 μF
- Available capacitance tolerances of ±5%, ±10% & ±20%
- · Non-polar device, minimizing installation concerns
- 100% pure matte tin-plated termination finish allowing for excellent solderability
- · Flexible termination option available upon request

Applications

Typical applications include decoupling, bypass, filtering and transient voltage suppression in extreme environments such as down-hole exploration, aerospace engine compartments and geophysical probes.

Application Notes

X7R dielectric is not recommended for AC line filtering or pulse applications.

Voltage derating of these capacitors is not required for application temperatures up to 175°C.

Qualification/Certification

High temperature Industrial grade products meet or exceed the requirements outlined Table 4, Performance & Reliability. Qualification packages are available upon request.



Environmental Compliance

Lead (Pb)-free, RoHS, and REACH compliant without exemptions.

Electrical Parameters/Characteristics

Item	Parameters/Characteristics
Operating Temperature Range	-55°C to +175°C
Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC)	±15% (-55°C to +125°C) beyond 125°C see "Capacitance vs. Temperature Performance" plot – Reference Only
Aging Rate (Maximum % Capacitance Loss/Decade Hour)	<3.0%
Dielectric Withstanding Voltage (DWV)	250% of rated voltage (5±1 seconds and charge/discharge not exceeding 50 mA)
Dissipation Factor (DF) Maximum Limit at 25°C	See Dissipation Factor Limit Table
Insulation Resistance (IR) Limit at 25°C	1,000 megohm microfarads or 100 GΩ (Rated voltage applied for 120±5 seconds at 25°C)

Regarding aging rate: Capacitance measurements (including tolerance) are indexed to a referee time of 1,000 hours. To obtain IR limit, divide $M\Omega$ - μ F value by the capacitance and compare to $G\Omega$ limit. Select the lower of the two limits.

Capacitance and dissipation factor (DF) measured under the following conditions:

1 kHz \pm 50 Hz and 1.0 \pm 0.2 Vrms if capacitance \leq 10 μ F

Note: When measuring capacitance it is important to ensure the set voltage level is held constant. The HP4284 and Agilent E4980 have a feature known as Automatic Level Control (ALC). The ALC feature should be switched to "ON."

Dissipation Factor Limit Table

Rated DC Voltage	Dissipation Factor
16/25	3.5%
> 25	2.5%

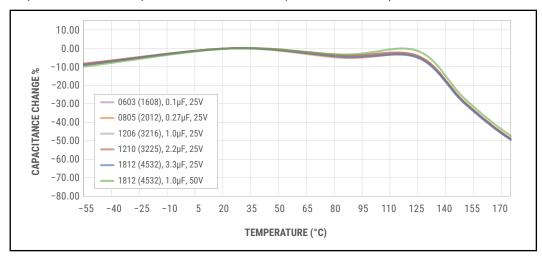
Post Environmental Limits

	High Temperature Life, Biased Humidity, Moisture Resistance										
Dielectric	Rated DC Voltage	Capacitance Value	Dissipation Factor (Maximum %)	Capacitance Shift	Insulation Resistance						
X7R	16/25	All	5.0	1.200/	10% of Initial						
A/R	>25	All	3.0	± 20%	Limit						

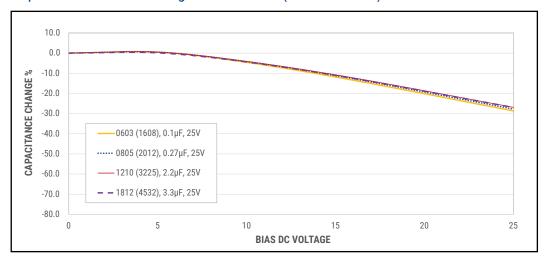


Electrical Characteristics

Capacitance vs. Temperature Performance (-55°C to +175°C)



Capacitance vs. Bias Voltage Performance (25 VDC Rated)



Capacitance vs. Bias Voltage Performance (1812 Case Size, 1.0 µF, 50 VDC Rated)

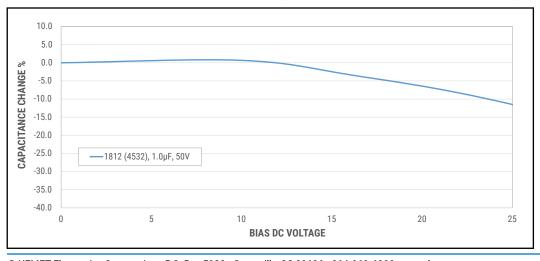




Table 1 - Capacitance Range/Selection Waterfall (0402 - 1812 Case Sizes)

			se Si Serie			C04	02G		CO	603(G/R	CO	8050	G/R	C1:	2060	G/R	C1:	2100	G/R		C181	2G/	R
Capacitance	Cap Code	Vol	tage C	ode	4	3	5	1	3	5	1	3	5	1	3	5	1	3	5	1	3	5	1	2
Capacitance	Cap Coue	Rate	ed Volt (VDC)	tage	16	25	50	100	25	50	100	25	50	100	25	50	100	25	50	100	25	50	100	200
			oacita oleran							F	Produc See	t Ava Table	ilabil 2 for	ity and Chip T	d Chip hickr	Thic less D	kness imens	Code sions	s					
2700 pF	272	J	K	М	BB	BB	BB																	
3300 pF	332	J	K	M	BB	BB	BB																	
3900 pF	392	J	K	М	BB	BB	BB																	
4700 pF	472	J	K	M	BB	BB	BB																	
5600 pF	562	J	K	М	ВВ	BB	BB																	
6800 pF	682	J	K	М	ВВ	BB	BB																	
8200 pF	822	J	K	М	ВВ	ВВ	ВВ		İ									l			İ			
10000 pF	103	j	K	м	ВВ	ВВ	BB														İ			
12000 pF	123	Ĵ	K	М	ВВ	BB																		
15000 pF	153	Ĵ	K	М	BB	BB			l															
18000 pF	183	Ĵ	K	M	BB	BB			CF	CF														
22000 pF	223	J	K	M	BB	BB			CF	CF														
27000 pF	273	J	K	M	טט	סט			CF	CF											ŀ			
· ·	333		K						CF	CF											ł			
33000 pF		J		M																	ŀ			
39000 pF	393	J	K	M					CF	CF		DNI	DAI											
47000 pF	473	J	K	М	BB				CF	CF		DN	DN								٠			
56000 pF	563	J	K	М					CF	CF		DN	DN								GN	GN	GN	GN
68000 pF	683	J	K	М					CF	CF		DN	DN											
82000 pF	823	J	K	М					CF	CF		DN	DN											
0.1 μF	104	J	K	М					CF	CF		DN	DN		ED	ED					GM	GM	GM	GM
0.12 μF	124	J	K	М					CF			DP	DP		ED	ED								
0.15 μF	154	J	K	М					CF			DP	DP		ED	ED								
0.18 μF	184	J	K	М								DF	DF		ED	ED		FE	FE					
0.22 μF	224	J	K	M								DG	DG		EP	EP		FE	FE		GB	GB		
0.27 μF	274	J	K	М								DG	DG		EP	EP		FF	FF		GB	GB		
0.33 μF	334	J	K	M								DP			EJ	EJ		FF	FF		GB	GB		
0.39 µF	394	J	K	M								DP			EJ	EJ		FG	FG		GB	GB		
0.47 µF	474	J	K	М					1			DG			EJ	EJ		FG	FG		GB	GB		
0.56 μF	564	J	K	М								DG			EP			FH	FH		GB	GB		
0.68 µF	684	J	K	М								DG			EJ			FM	FM		GC	GC		
0.82 µF	824	J	K	М											EJ			FK	FK		GE	GE		
1 μF	105	J	K	М											EJ			FK	FK		GH	GH		
1.2 µF	125	J	K	М														FH			GJ	GJ		
1.5 µF	155	Ĵ	K	М														FM			GL	GL		
1.8 µF	185	Ĵ	K	М														FK			GE			
2.2 μF	225	Ĵ	K	М														FK			GG			
2.7 μF	275	Ĵ	K	М					i									l			GJ			
3.3 μF	335	Ĵ	K	М					i												GL			
σ.σ μι	000	·	ed Volt		16	25	50	100	25	50	100	25	50	100	25	50	100	25	50	100	25	50	100	200
Capacitance	Cap Code	Vol	(VDC) tage C	odo	4	3	5	1	3	5	1	3	5	1	3	5	1	3	5	1	3	5	1	2
vaharitaiire	cap coue				┝┸		_ J	<u>'</u>	L"					<u>'</u>	L	J		Ľ		<u>'</u>	Ļ			
			se Siz Series			C04	02G		C	603G	/R	CC	805G	/R	C1	1206G	/R	C1	1210G	/R		C181	2G/R	



Table 2 – Chip Thickness/Packaging Quantities

Thickness	Case	Thickness ±	Paper C	Quantity	Plastic (Quantity
Code	Size	Range (mm)	7" Reel	13" Reel	7" Reel	13" Reel
BB	0402	0.50 ± 0.05	10,000	50,000	0	0
CF	0603	0.80 ± 0.07*	4,000	15,000	0	0
DN	0805	0.78 ± 0.10*	4,000	15,000	0	0
DP	0805	0.90 ± 0.10*	4,000	15,000	0	0
DF	0805	1.10 ± 0.10	0	0	2,500	10,000
DG	0805	1.25 ± 0.15	0	0	2,500	10,000
ED	1206	1.00 ± 0.10	0	0	2,500	10,000
EP	1206	1.20 ± 0.20	0	0	2,500	10,000
EJ	1206	1.70 ± 0.20	0	0	2,000	8,000
FE	1210	1.00 ± 0.10	0	0	2,500	10,000
FF	1210	1.10 ± 0.10	0	0	2,500	10,000
FG	1210	1.25 ± 0.15	0	0	2,500	10,000
FH	1210	1.55 ± 0.15	0	0	2,000	8,000
FM	1210	1.70 ± 0.20	0	0	2,000	8,000
FK	1210	2.10 ± 0.20	0	0	2,000	8,000
GB	1812	1.00 ± 0.10	0	0	1,000	4,000
GC	1812	1.10 ± 0.10	0	0	1,000	4,000
GE	1812	1.30 ± 0.10	0	0	1,000	4,000
GH	1812	1.40 ± 0.15	0	0	1,000	4,000
GG	1812	1.55 ± 0.10	0	0	1,000	4,000
GJ	1812	1.70 ± 0.15	0	0	1,000	4,000
GN	1812	1.70 ± 0.20	0	0	1,000	4,000
GL	1812	1.90 ± 0.20	0	0	500	2,000
GM	1812	2.00 ± 0.20	0	0	500	2,000
Thickness	Case	Thickness ±	7" Reel	13" Reel	7" Reel	13" Reel
Code	Size	Range (mm)	Paper C	Quantity	Plastic (Quantity

Package quantity based on finished chip thickness specifications.



Table 3A - Land Pattern Design Recommendations per IPC-7351 - Standard Termination

EIA Size Code	Metric Size Code	ı	Maxi	sity Lev mum (I rotrusio	Most))	ı	Density Level B: Median (Nominal) Land Protrusion (mm)					Density Level C: Minimum (Least) Land Protrusion (mm)					
Code	Code	C	Y	X	V 1	V2	C	Y	X	V 1	V2	C	Y	X	V1	V2		
0402	1005	0.50	0.72	0.72	2.20	1.20	0.45	0.62	0.62	1.90	1.00	0.40	0.52	0.52	1.60	0.80		
0603	1608	0.90	1.15	1.10	4.00	2.10	0.80	0.95	1.00	3.10	1.50	0.60	0.75	0.90	2.40	1.20		
0805	2012	1.00	1.35	1.55	4.40	2.60	0.90	1.15	1.45	3.50	2.00	0.75	0.95	1.35	2.80	1.70		
1206	3216	1.60	1.35	1.90	5.60	2.90	1.50	1.15	1.80	4.70	2.30	1.40	0.95	1.70	4.00	2.00		
1210	3225	1.60	1.35	2.80	5.65	3.80	1.50	1.15	2.70	4.70	3.20	1.40	0.95	2.60	4.00	2.90		
1812	4532	2.15	1.60	3.60	6.90	4.60	2.05	1.40	3.50	6.00	4.00	1.95	1.20	3.40	5.30	3.70		

Density Level A: For low-density product applications. Recommended for wave solder applications and provides a wider process window for reflow solder processes. KEMET only recommends wave soldering of EIA 0603, 0805 and 1206 case sizes.

Density Level B: For products with a moderate level of component density. Provides a robust solder attachment condition for reflow solder processes. **Density Level C:** For high component density product applications. Before adapting the minimum land pattern variations the user should perform qualification testing based on the conditions outlined in IPC Standard 7351 (IPC-7351).

Image below based on Density Level B for an EIA 1210 case size.

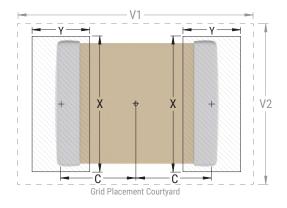




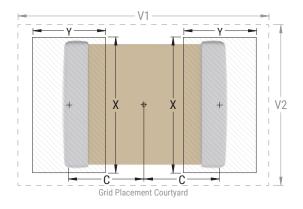
Table 3B - Land Pattern Design Recommendations per IPC-7351 - Flexible Termination

EIA Size Code	Metric Size Code	ı		sity Lev mum (N rotrusio	Most))	ı	Media	sity Lev an (Nor rotrusio)	Density Level C: Minimum (Least) Land Protrusion (mm)					
Code	Code	С	Y	X	V 1	V2	С	Y	X	V1	V2	С	Y	X	V1	V2	
0603	1608	0.85	1.25	1.10	4.00	2.10	0.75	1.05	1.00	3.10	1.50	0.65	0.85	0.90	2.40	1.20	
0805	2012	0.99	1.44	1.66	4.47	2.71	0.89	1.24	1.56	3.57	2.11	0.79	1.04	1.46	2.42	1.81	
1206	3216	1.59	1.62	2.06	5.85	3.06	1.49	1.42	1.96	4.95	2.46	1.39	1.22	1.86	4.25	2.16	
1210	3225	1.59	1.62	3.01	5.90	4.01	1.49	1.42	2.91	4.95	3.41	1.39	1.22	2.81	4.25	3.11	
1812	4532	2.10	1.80	3.60	7.00	4.60	2.00	1.60	3.50	6.10	4.00	1.90	1.40	3.40	5.40	3.70	

Density Level A: For low-density product applications. Recommended for wave solder applications and provides a wider process window for reflow solder processes. KEMET only recommends wave soldering of EIA 0603, 0805 and 1206 case sizes.

Density Level B: For products with a moderate level of component density. Provides a robust solder attachment condition for reflow solder processes. **Density Level C:** For high component density product applications. Before adapting the minimum land pattern variations the user should perform qualification testing based on the conditions outlined in IPC Standard 7351 (IPC-7351).

Image below based on Density Level B for an EIA 1210 case size.





Soldering Process

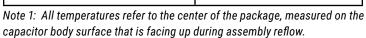
Recommended Soldering Technique:

- Solder wave or solder reflow for EIA case sizes 0603, 0805 and 1206
- · All other EIA case sizes are limited to solder reflow only

Recommended Reflow Soldering Profile:

KEMET's families of surface mount multilayer ceramic capacitors (SMD MLCCs) are compatible with wave (single or dual), convection, IR or vapor phase reflow techniques. Preheating of these components is recommended to avoid extreme thermal stress. KEMET's recommended profile conditions for convection and IR reflow reflect the profile conditions of the IPC/J-STD-020 standard for moisture sensitivity testing. These devices can safely withstand a maximum of three reflow passes at these conditions.

Profile Feature	Termination Finish					
1 Tome reature	100% Matte Sn					
Preheat/Soak						
Temperature Minimum (T _{Smin})	150°C					
Temperature Maximum (T _{Smax})	200°C					
Time (t_s) from T_{smin} to T_{smax}	60 – 120 seconds					
Ramp-Up Rate (T _L to T _P)	3°C/second maximum					
Liquidous Temperature (T _L)	217°C					
Time Above Liquidous (t _L)	60 - 150 seconds					
Peak Temperature (T _P)	260°C					
Time Within 5°C of Maximum Peak Temperature (t _p)	30 seconds maximum					
Ramp-Down Rate (T _P to T _L)	6°C/second maximum					
Time 25°C to Peak Temperature	8 minutes maximum					



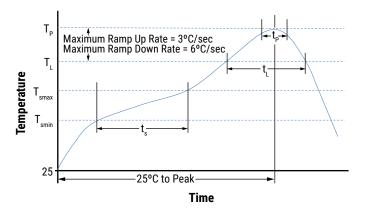




Table 4 - Performance & Reliability: Test Methods and Conditions

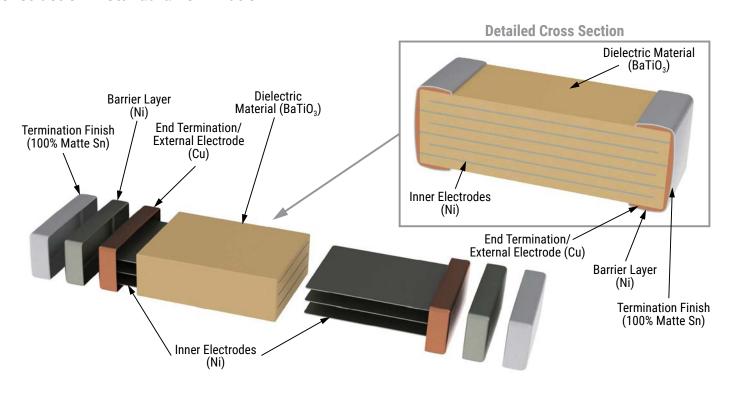
Stress	Reference	Test or Inspection Method								
		Appendix 1, Note:								
		Package Size (L" x W") Force Duration								
Terminal Strength	JIS-C-6429	JIS-C-6429	JIS-C-6429	JIS-C-6429	0402 5 N (0.51 kg) 60 seconds					
		0603 10 N (1.02 kg)								
		≥ 0805 18 N (1.83 kg)								
Board Flex	JIS-C-6429	Appendix 2, Note: Standard termination system – 2.0 mm (minimum) for all except 3 mm for COG. Flexible termination system – 3.0 mm (minimum).								
		Magnification 50 X. Conditions:								
Caldarahilitu	J-STD-002	a) Method B, 4 hours at 155°C, dry heat at 235°C								
Solderability	J-21D-002	b) Method B at 215°C category 3								
		c) Method D, category 3 at 260°C								
Temperature Cycling	KEMET defined	50 cycles (-55°C to +220°C). Measurement at 24 hours +/- 4 hours after test conclusion.								
	MIL-STD-202 Method	Load Humidity: 1,000 hours 85°C/85% RH and rated voltage. Add 100 K ohm resistor. Measurement at 24 hours +/-4 hours after test conclusion.								
Biased Humidity	103	Low Volt Humidity: 1,000 hours 85°C/85% RH and 1.5 V. Add 100 K ohm resistor. Measurement at 24 hours +/-4 hours after test conclusion.								
Moisture Resistance	MIL-STD-202 Method 106	t = 24 hours/cycle. Steps 7a and 7b not required. Unpowered. Measurement at 24 hours +/-2 hours after test conclusion.								
High Temperature Life	MIL-STD-202 Method 108 /EIA-198	1,000 hours at 175°C with 2 X rated voltage applied.								
Storage Life	KEMET defined	200°C, 0 VDC for 1,000 hours.								
Vibration	MIL-STD-202 Method 204	5 g's for 20 minutes, 12 cycles each of 3 orientations. Note: Use 8" X 5" PCB 0.031" thick 7 secure points on one long side and 2 secure points at corners of opposite sides. Parts mounted within 2" from any secure point. Test from $10 - 2,000 \text{Hz}$								
Mechanical Shock	MIL-STD-202 Method 213	Figure 1 of Method 213, Condition F.								
Resistance to Solvents	MIL-STD-202 Method 215	Add aqueous wash chemical, OKEM Clean or equivalent.								

Storage and Handling

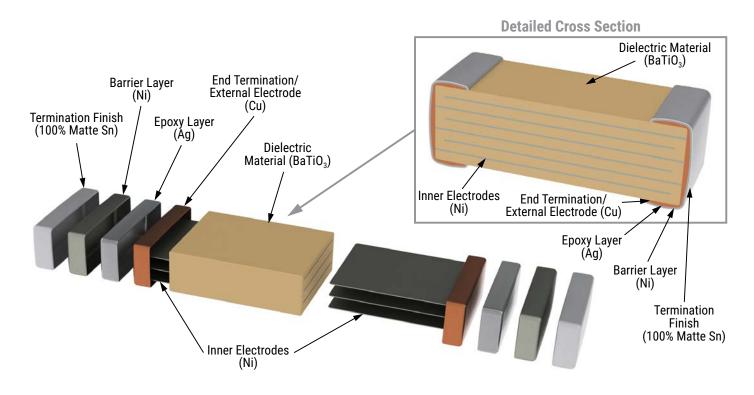
Ceramic chip capacitors should be stored in normal working environments. While the chips themselves are quite robust in other environments, solderability will be degraded by exposure to high temperatures, high humidity, corrosive atmospheres, and long term storage. In addition, packaging materials will be degraded by high temperature – reels may soften or warp and tape peel force may increase. KEMET recommends that maximum storage temperature not exceed 40°C and maximum storage humidity not exceed 70% relative humidity. Temperature fluctuations should be minimized to avoid condensation on the parts and atmospheres should be free of chlorine and sulfur bearing compounds. For optimized solderability chip stock should be used promptly, preferably within 1.5 years of receipt.



Construction – Standard Termination



Construction – Flexible Termination





Capacitor Marking (Optional):

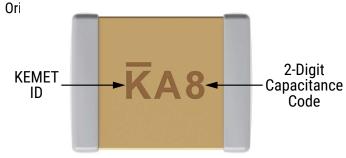
These surface mount multilayer ceramic capacitors are normally supplied unmarked. If required, they can be marked as an extra cost option. Marking is available on most KEMET devices but must be requested using the correct ordering code identifier(s). If this option is requested, two sides of the ceramic body will be laser marked with a "K" to identify KEMET, followed by two characters (per EIA-198 - see table below) to identify the capacitance value. EIA 0603 case size devices are limited to the "K" character only.

Laser marking option is <u>not</u> available on:

- COG, Ultra Stable X8R and Y5V dielectric devices
- EIA 0402 case size devices
- EIA 0603 case size devices with Flexible Termination option.
- KPS Commercial and Automotive Grade stacked devices.

•	X7R dielectric products	in capacitance	values	outlin	ed
	below				

Marking appears in legible contrast. Illustrated below is an example of an MLCC with laser marking of "KA8", which designates a KEMET device with rated capacitance of 100 µF.



EIA Case Size	Metric Size Code	Capacitance
0603	1608	≤ 170 pF
0805	2012	≤ 150 pF
1206	3216	≤ 910 pF
1210	3225	≤ 2,000 pF
1808	4520	≤ 3,900 pF
1812	4532	≤ 6,700 pF
1825	4564	≤ 0.018 µF
2220	5650	≤ 0.027 µF
2225	5664	≤ 0.033 µF



Capacitor Marking (Optional) cont'd

		anacita	nce (n	F) For \	/arinus	Δlnha/	Numera	al Identif	iers	
		upacito	пое (р	, , , , ,		Numera		ii ideiitii	1013	
Alpha	9	0	1	2	3	4	5	6	7	8
Character			· ·	_		citance			•	
A	0.1	10	10	100	1,000	10,000	100,000	1,000,000	10,000,000	100,000,000
В	0.11	1.1	11	110	1,100	11,000	110,000	1,100,000	11,000,000	110,000,000
С	0.12	12	12	120	1,200	12,000	120,000	1,200,000	12,000,000	120,000,000
D	0.13	13	13	130	1,300	13,000	130,000	1,300,000	13,000,000	130,000,000
E	0.15	1 5	15	150	1,500	15,000	150,000	1,500,000	15,000,000	150,000,000
F	0.16	16	16	160	1,600	16,000	160,000	1,600,000	16,000,000	160,000,000
G	0.18	18	18	180	1,800	18,000	180,000	1,800,000	18,000,000	180,000,000
Н	0.2	2 0	20	200	2,000	20,000	200,000	2,000,000	20,000,000	200,000,000
J	0.22	2 2	22	220	2,200	22,000	220,000	2,200,000	22,000,000	220,000,000
K	0.24	2.4	24	240	2,400	24,000	240,000	2,400,000	24,000,000	240,000,000
L	0.27	2.7	27	270	2,700	27,000	270,000	2,700,000	27,000,000	270,000,000
М	0.3	3 0	30	300	3,000	30,000	300,000	3,000,000	30,000,000	300,000,000
N	0.33	3 3	33	330	3,300	33,000	330,000	3,300,000	33,000,000	330,000,000
Р	0.36	3 6	36	360	3,600	36,000	360,000	3,600,000	36,000,000	360,000,000
Q	0.39	3 9	39	390	3,900	39,000	390,000	3,900,000	39,000,000	390,000,000
R	0.43	4 3	43	430	4,300	43,000	430,000	4,300,000	43,000,000	430,000,000
S	0.47	4.7	47	470	4,700	47,000	470,000	4,700,000	47,000,000	470,000,000
Т	0.51	5.1	51	510	5,100	51,000	510,000	5,100,000	51,000,000	510,000,000
U	0.56	5 6	56	560	5,600	56,000	560,000	5,600,000	56,000,000	560,000,000
٧	0.62	6 2	62	620	6,200	62,000	620,000	6,200,000	62,000,000	620,000,000
W	0.68	6 8	68	680	6,800	68,000	680,000	6,800,000	68,000,000	680,000,000
Х	0.75	7 5	75	750	7,500	75,000	750,000	7,500,000	75,000,000	750,000,000
Υ	0.82	8 2	82	820	8,200	82,000	820,000	8,200,000	82,000,000	820,000,000
Z	0.91	9.1	91	910	9,100	91,000	910,000	9,100,000	91,000,000	910,000,000
а	0.25	2 5	25	250	2,500	25,000	250,000	2,500,000	25,000,000	250,000,000
b	0.35	3 5	35	350	3,500	35,000	350,000	3,500,000	35,000,000	350,000,000
d	0.4	4 0	40	400	4,000	40,000	400,000	4,000,000	40,000,000	400,000,000
е	0.45	4 5	45	450	4,500	45,000	450,000	4,500,000	45,000,000	450,000,000
f	0.5	5 0	50	500	5,000	50,000	500,000	5,000,000	50,000,000	500,000,000
m	0.6	6 0	60	600	6,000	60,000	600,000	6,000,000	60,000,000	600,000,000
n	0.7	7 0	70	700	7,000	70,000	700,000	7,000,000	70,000,000	700,000,000
t	0.8	8 0	80	800	8,000	80,000	800,000	8,000,000	80,000,000	800,000,000
у	0.9	9 0	90	900	9,000	90,000	900,000	9,000,000	90,000,000	900,000,000



Tape & Reel Packaging Information

KEMET offers multilayer ceramic chip capacitors packaged in 8, 12 and 16 mm tape on 7" and 13" reels in accordance with EIA Standard 481. This packaging system is compatible with all tape-fed automatic pick and place systems. See Table 2 for details on reeling quantities for commercial chips.

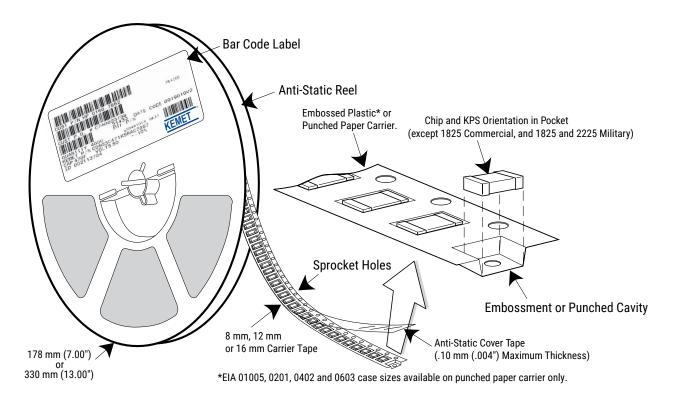


Table 5 - Carrier Tape Configuration, Embossed Plastic & Punched Paper (mm)

	Tape	Embosse	ed Plastic	Punched Paper		
EIA Case Size	Size	7" Reel	13" Reel	7" Reel	13" Reel	
	(W)*	Pitch	(P ₁)*	Pitch	(P ₁)*	
01005 - 0402	8			2	2	
0603	8			2/4	2/4 -	
0805	8	4	4	4	4	
1206 - 1210	8	4	4	4	4	
1805 - 1808	12	4	4			
≥ 1812	12	8	8			
KPS 1210	12	8	8			
KPS 1812 & 2220	16	12	12			
Array 0508 & 0612	8	4	4			

^{*}Refer to Figures 1 & 2 for W and P_1 carrier tape reference locations.

New 2 mm Pitch Reel Options*

	Packaging Ordering Code (C-Spec)	Packaging Type/Options
1	C-3190	Automotive grade 7" reel unmarked
١	C-3191	Automotive grade 13" reel unmarked
	C-7081	Commercial grade 7" reel unmarked
	C-7082	Commercial grade 13" reel unmarked

^{* 2} mm pitch reel only available for 0603 EIA case size. 2 mm pitch reel for 0805 EIA case size under development.

Benefits of Changing from 4 mm to 2 mm Pitching Spacing

- · Lower placement costs
- Double the parts on each reel results in fewer reel changes and increased efficiency
- Fewer reels result in lower packaging, shipping and storage costs, reducing waste

^{*}Refer to Tables 6 & 7 for tolerance specifications.



Figure 1 - Embossed (Plastic) Carrier Tape Dimensions

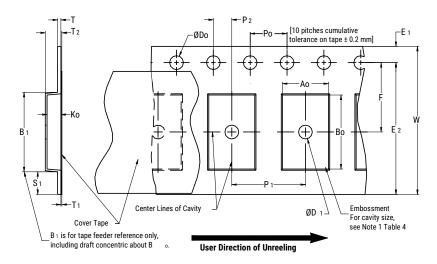


Table 6 – Embossed (Plastic) Carrier Tape Dimensions

Metric will govern

	Constant Dimensions — Millimeters (Inches)									
Tape Size	D ₀	D ₁ Minimum Note 1	E ₁	P ₀	P ₂	R Reference Note 2	S ₁ Minimum Note 3	T Maximum	T ₁ Maximum	
8 mm	15.010/00	1.0 (0.039)				25.0 (0.984)				
12 mm	1.5 +0.10/-0.0 (0.059 +0.004/- 0.0)	m (0.059 +0.004/-	1.5	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	30	0.600 (0.024)	0.600 (0.024)	0.100 (0.004)
16 mm	0.0)	(0.059)				(1.181)				
		,	Variable Dime	ensions — Mil	limeters (Incl	nes)				
Tape Size	Pitch	B ₁ Maximum Note 4	E ₂ Minimum	F	P ₁	T ₂ Maximum	W Maximum	A ₀ ,B ₀	& K ₀	
8 mm	Single (4 mm)	4.35 (0.171)	6.25 (0.246)	3.5 ±0.05 (0.138 ±0.002)	4.0 ±0.10 (0.157 ±0.004)	2.5 (0.098)	8.3 (0.327)			
12 mm	Single (4 mm) & Double (8 mm)	8.2 (0.323)	10.25 (0.404)	5.5 ±0.05 (0.217 ±0.002)	8.0 ±0.10 (0.315 ±0.004)	4.6 (0.181)	12.3 (0.484)	Note 5		
16 mm	Triple (12 mm)	12.1 (0.476)	14.25 (0.561)	7.5 ±0.05 (0.138 ±0.002)	12.0 ±0.10 (0.157 ±0.004)	4.6 (0.181)	16.3 (0.642)			

- 1. The embossment hole location shall be measured from the sprocket hole controlling the location of the embossment. Dimensions of embossment location and hole location shall be applied independent of each other.
- 2. The tape with or without components shall pass around R without damage (see Figure 6).
- 3. If S, < 1.0 mm, there may not be enough area for cover tape to be properly applied (see EIA Standard 481 paragraph 4.3 section b).
- 4. B, dimension is a reference dimension for tape feeder clearance only.
- 5. The cavity defined by A_{o} , B_{o} and K_{o} shall surround the component with sufficient clearance that:
 - (a) the component does not protrude above the top surface of the carrier tape.
 - (b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.
 - (c) rotation of the component is limited to 20° maximum for 8 and 12 mm tapes and 10° maximum for 16 mm tapes (see Figure 3).
 - (d) lateral movement of the component is restricted to 0.5 mm maximum for 8 and 12 mm wide tape and to 1.0 mm maximum for 16 mm tape (see Figure 4).
 - (e) for KPS Series product, A, and B, are measured on a plane 0.3 mm above the bottom of the pocket.
 - (f) see Addendum in EIA Standard 481 for standards relating to more precise taping requirements.



Figure 2 - Punched (Paper) Carrier Tape Dimensions

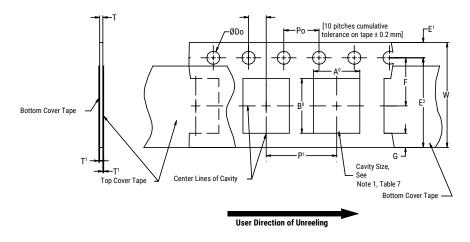


Table 7 - Punched (Paper) Carrier Tape Dimensions

Metric will govern

	Constant Dimensions — Millimeters (Inches)									
Tape Size	D ₀	E ₁	P ₀	P ₂	T ₁ Maximum	G Minimum	R Reference Note 2			
8 mm	1.5 +0.10 -0.0 (0.059 +0.004 -0.0)	1.75 ±0.10 (0.069 ±0.004)	4.0 ±0.10 (0.157 ±0.004)	2.0 ±0.05 (0.079 ±0.002)	0.10 (0.004) Maximum	0.75 (0.030)	25 (0.984)			
		Variable D	imensions – M	illimeters (Inche	es)					
Tape Size Pitch E2 Minimum F P ₁ T Maximum						W Maximum	A_0B_0			
8 mm	Half (2 mm)	6.25 3.5 ±0.05	2.0 ±0.05 (0.079 ±0.002)	1.1	8.3 (0.327)	Note 1				
8 mm	Single (4 mm)	(0.246)	(0.138 ±0.002)	4.0 ±0.10 (0.157 ±0.004)	(0.098)	8.3 (0.327)	Note 1			

- 1. The cavity defined by A_{n} , B_{n} and T shall surround the component with sufficient clearance that:
 - a) the component does not protrude beyond either surface of the carrier tape.
 - b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the top cover tape has been removed.
 - c) rotation of the component is limited to 20° maximum (see Figure 3).
 - d) lateral movement of the component is restricted to 0.5 mm maximum (see Figure 4).
 - e) see Addendum in EIA Standard 481 for standards relating to more precise taping requirements.
- 2. The tape with or without components shall pass around R without damage (see Figure 6).



Packaging Information Performance Notes

1. Cover Tape Break Force: 1.0 Kg minimum.

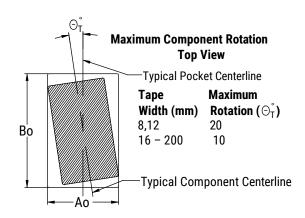
2. Cover Tape Peel Strength: The total peel strength of the cover tape from the carrier tape shall be:

Tape Width	Peel Strength
8 mm	0.1 to 1.0 Newton (10 to 100 gf)
12 and 16 mm	0.1 to 1.3 Newton (10 to 130 gf)

The direction of the pull shall be opposite the direction of the carrier tape travel. The pull angle of the carrier tape shall be 165° to 180° from the plane of the carrier tape. During peeling, the carrier and/or cover tape shall be pulled at a velocity of 300 ±10 mm/minute.

3. Labeling: Bar code labeling (standard or custom) shall be on the side of the reel opposite the sprocket holes. *Refer to EIA Standards 556 and 624*.

Figure 3 – Maximum Component Rotation



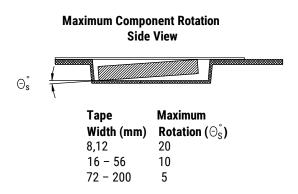


Figure 4 - Maximum Lateral Movement

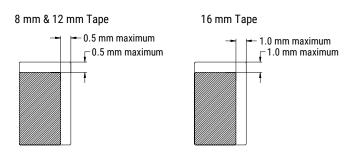


Figure 5 - Bending Radius

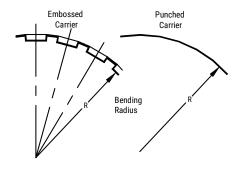
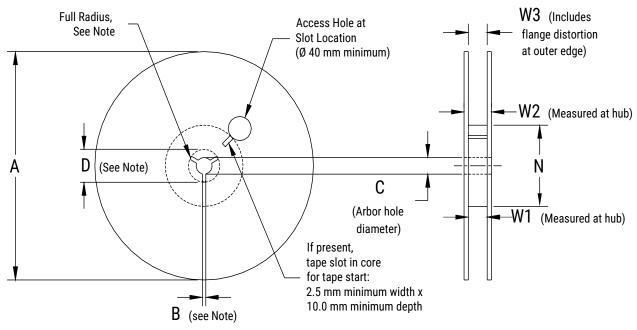




Figure 6 - Reel Dimensions



Note: Drive spokes optional; if used, dimensions B and D shall apply.

Table 8 - Reel Dimensions

Metric will govern

Constant Dimensions — Millimeters (Inches)									
Tape Size	A	B Minimum	С	D Minimum					
8 mm	178 ±0.20								
12 mm	(7.008 ±0.008) or	1.5 (0.059)	13.0 +0.5/-0.2 (0.521 +0.02/-0.008)	20.2 (0.795)					
16 mm	330 ±0.20 (13.000 ±0.008)	(***)	(* * * * * * * * * * * * * * * * * * *	(3.123)					
	Variable	Dimensions — Millimeter	rs (Inches)						
Tape Size	N Minimum	W ₁	W ₂ Maximum	W ₃					
8 mm		8.4 +1.5/-0.0 (0.331 +0.059/-0.0)	14.4 (0.567)						
12 mm	50 (1.969)	12.4 +2.0/-0.0 (0.488 +0.078/-0.0)	18.4 (0.724)	Shall accommodate tape width without interference					
16 mm		16.4 +2.0/-0.0 (0.646 +0.078/-0.0)	22.4 (0.882)						



Figure 7 - Tape Leader & Trailer Dimensions

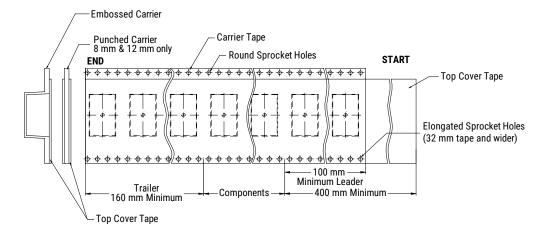
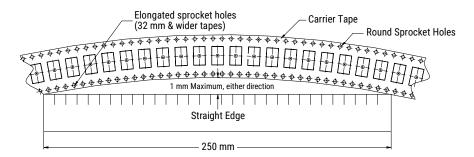


Figure 8 – Maximum Camber





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